

**Notice of References Cited**

Application/Control No.

10/567,491

Applicant(s)/Patent Under  
Reexamination  
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Examiner

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Art Unit

1794

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2,154,449 A	04-1939	CHARLES HOFFMAN et al.	426/9
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	J	US-			
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Titration of weak acid with strong base <input type="checkbox"/> <a href="http://www.chem.ufl.edu/~itl/2045/lectures/lec_z2.html">Http://www.chem.ufl.edu/~itl/2045/lectures/lec_z2.html</a>
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